EXCELLENT PUBLISHERS

International Journal of Current Microbiology and Applied Sciences (IJCMAS)

ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

An International, Monthly, Online, Free Access, Peer Reviewed, Indexed, Scientific Research Journal

CERTIFICATE OF PUBLICATION

This is to certify that the following article reviewed by editorial board and published in

International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2021.10.(3):967-973

https://doi.org/10.20546/ijcmas.2021.1003.123

Statistical Models for Wheat Yield Forecasting using Discriminant Function Analysis of Weather Parameters

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International Journal of Current Microbiology and Applied Sciences
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